

AMENDMENTS TO THE CLAIMS

1. (Original) A semiconductor integrated circuit device having a second storage means in a semiconductor integrated circuit, in which a program that makes an arithmetic processing unit in the semiconductor integrated circuit perform an operation of processing contents is rewritably stored, and performing rewriting of the program stored in the second storage means using a first storage means in which a rewrite program for rewriting is stored, which rewrite program makes the arithmetic processing unit perform an operation of processing the contents;

wherein said second storage means has an externally readable area that can be read from the outside of the semiconductor integrated circuit, and an externally unreadable area that cannot be read from the outside; and

after arbitrary data is stored in the externally readable area of the second storage means, the data is read to the outside of the semiconductor integrated circuit to check whether the arbitrary data is the data as inputted, and thereafter, the rewrite program read from the first storage means is stored in the externally unreadable area of the second storage means.

2. (Original) A semiconductor integrated circuit device having a second storage means in a semiconductor integrated circuit, in which a program that makes an arithmetic processing unit in the semiconductor integrated circuit perform an operation of processing contents is rewritably stored, and performing rewriting of the program stored in the second storage means using a first storage means in which a rewrite program for rewriting is stored, which rewrite program makes the arithmetic processing unit perform an operation of processing the contents, said semiconductor integrated circuit device including:

a control circuit for performing control so as to read only a specific portion of the rewrite program stored in the second storage means.

3. (Original) A semiconductor integrated circuit device as defined in Claim 2 wherein said control circuit performs control so as to read only the rewrite program located in specific addresses of the second storage means.

4. (Original) A semiconductor integrated circuit device as defined in Claim 2 wherein said control circuit performs control so as to read only specific bits of the rewrite program stored in the second storage means.

5. (Original) A semiconductor integrated circuit device having a second storage means in a semiconductor integrated circuit, in which a program that makes an arithmetic processing unit in the semiconductor integrated circuit perform an operation of processing contents is rewritably stored, and performing rewriting of the program stored in the second storage means using a first storage means in which a rewrite program for rewriting is stored, which rewrite program makes the arithmetic processing unit perform an operation of processing the contents;

wherein said rewrite program includes a program for executing a portion of the rewrite program after the rewriting; and

the portion of the rewrite program stored in the second storage means is executed.

6. (Original) A semiconductor integrated circuit device as defined in Claim 5 wherein the portion of the rewrite program to be executed is one for successively executing discontinuous program areas.

7. (Currently Amended) A semiconductor integrated circuit device having a second storage means in a semiconductor integrated circuit, in which a program that makes an arithmetic processing unit in the semiconductor integrated circuit perform an operation of processing contents is rewritably stored, and performing rewriting of the program stored in the second storage means using a first storage means in which a rewrite program for rewriting is stored, which rewrite program makes the arithmetic processing unit perform an operation of processing the contents; and

said semiconductor integrated circuit device including, in the semiconductor integrated circuit, a transfer monitor means for monitoring ~~transfer error of~~ transfer errors of the rewrite program to be transferred from the first storage means to the second storage means.

8. (Original) A semiconductor integrated circuit device having a second storage means in a semiconductor integrated circuit, in which a program that makes an arithmetic processing unit in the semiconductor integrated circuit perform an operation of processing contents is rewritably stored, and performing rewriting of the program stored in the second storage means using a first storage means in which a rewrite program for rewriting is stored, which rewrite program makes the arithmetic processing unit perform an operation of processing the contents;

wherein the rewrite program includes a check program for checking whether the program is correct or not;

the semiconductor integrated circuit is provided with a work memory for the arithmetic processing unit, and a connection switching means for switching the connection between the second storage means or the work memory, and the program input or the data input of the arithmetic processing unit; and

the check program that is extracted from the rewrite program stored in the second storage means is stored in the work memory, and the arithmetic processing unit is operated by the check program stored in the work memory, thereby to check whether the rewrite program is correct or not.

9. (Original) A semiconductor integrated circuit device as defined in Claim 8 wherein the second storage means holds the rewrite program, and holds data which is uniquely obtained from a predetermined cluster in the rewrite program, according to a predetermined rule.

10. (Original) A semiconductor integrated circuit device as defined in Claim 9 wherein the uniquely obtained data is used as a check code for checking whether the program is correct or not.

11. (Original) A semiconductor integrated circuit device as defined in Claim 8 wherein the second storage means has a construction in which an area where the rewrite program is not stored is successively divided into two areas, and the same program is stored in each of the two areas;

the check program includes

a program for comparing the program data stored in one of the two areas with the same data stored in the other area, thereby to check whether the program data is correct or not, and

a program for, when the result of the previous check is that the program data is correct, repeating an operation of further dividing one of the two areas, as an area wherein no program is stored, into two areas, and storing the same program data in each of the two areas; and

all of the programs to be stored in the second storage means are successively stored.

12. (Original) A semiconductor integrated circuit device as defined in Claim 11 wherein the second storage means stores the rewrite program data, and data that is uniquely obtained from the program data according to a predetermined rule, in the two areas into which the area in the second storage means where the rewrite program is not stored is successively divided.

13. (Original) A semiconductor integrated circuit device as defined in Claim 12 wherein the uniquely obtained data is inverted data of the program data.

14. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 8 further including a ROM (Read Only Memory) in which the check program is previously stored; wherein the arithmetic processing unit is operated by the ROM to check whether the rewrite program is correct or not.

15. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 1 further including, in the semiconductor integrated circuit, a decryption means for decrypting the encrypted rewrite program;

wherein, when the rewrite program stored in the first storage means has previously been encrypted, the decryption means decrypts the encrypted program, and stores the decrypted rewrite program in the second storage means.

16. (Original) A semiconductor integrated circuit device having a second storage means in a semiconductor integrated circuit, in which a program that makes an arithmetic processing unit in the semiconductor integrated circuit perform an operation of processing contents is rewritably stored, and performing rewriting using a first storage means in which a previously encrypted rewrite program for rewriting is stored, which rewrite program makes the arithmetic processing unit perform an operation of processing the contents;

said semiconductor integrated circuit device including, in the semiconductor integrated circuit,

a decryption means for decrypting the encrypted rewrite program read from the first storage means, and transferring the decrypted rewrite program to the second storage means; and

an encryption means for again encrypting the rewrite program stored in the second storage means;

wherein the rewrite program encrypted by the encryption means is compared with the encrypted rewrite program stored in the first storage means.

17. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 11 wherein, when data are not correctly stored in the second storage means, a defective portion is detected, and the rewrite program stored in the first storage means is corrected.

18. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 1 wherein the rewrite program that is stored outside the semiconductor integrated circuit device is downloadable into the semiconductor integrated circuit.

19. (Currently Amended) A data storage verification device comprising:

means for storing arbitrary data ~~in an area~~ a storage means having in a storage means having an area which is accessible from the outside;

means for outputting the arbitrary data to the outside, and judging whether the arbitrary data is correctly stored or not; and

means for storing secret data in a storage means having an area which is inaccessible from the outside, when it is judged that the arbitrary data is correctly stored.

20. (Canceled)

21. (Canceled)

22. (Previously Presented) A data storage verification device comprising:

first means for storing secret data including an inspection program and a secret program into a storage means having an area which is inaccessible from the outside;

second means for executing the inspection program, and outputting the result to the outside;
and

third means for executing the secret program after completion of the second means.

23. (Previously Presented) A data storage verification device comprising:

means for storing secret data in a storage means having an area which is inaccessible from the outside;

means for performing a predetermined arithmetic operation using the secret data, simultaneously with the storage; and

means for outputting the result of the arithmetic operation to the outside.

24. (Previously Presented) A data storage verification device comprising:

fourth means for storing secret data in a storage means having a first area which is inaccessible from the outside;

fifth means for storing an inspection program which is a part of the secret data and is stored in the first area, into a storage means having a second area; and

sixth means for executing the inspection program stored in the second area to verify correctness of the secret data stored in the first area.

25. (Original) A data storage verification device as defined in Claim 24 further including seventh means for transferring control to a command of the first area after completion of the sixth means.

26. (Original) A data storage verification device as defined in Claim 24 wherein the fifth means executes storage of the inspection program according to a command that exists in the secret data stored in the first area.

27. (Original) A data storage verification device as defined in Claim 24 wherein the fifth means executes the inspection program according to a command that has been stored in a third area before execution of storage by the fourth means.

28. (Previously Presented) A data storage verification device comprising:
means for decrypting secret data;
means for storing the decrypted data in a storage means having an area which is inaccessible from the outside;
means for encrypting the stored data; and
means for comparing the encrypted data with the secret data to judge whether the stored data is correctly stored or not.

29. (Canceled)

30. (Previously Presented) A data storage verification method comprising:
step of storing arbitrary data in a storage means having an area which is accessible from the outside;
step of outputting the arbitrary data to the outside, and judging whether the arbitrary data is correctly stored or not; and
step of storing secret data in a storage means having an area which is inaccessible from the outside, when it is judged that the arbitrary data is correctly stored.

31. (Canceled)
32. (Canceled)
33. (Previously Presented) A data storage verification method comprising:
first step of storing secret data including an inspection program and a secret program into a storage means having an area which is inaccessible from the outside;
second step of executing the inspection program, and outputting the result to the outside; and
third step of executing the secret program after completion of the second step.
34. (Previously Presented) A data storage verification method comprising:
step of storing secret data in a storage means having an area which is inaccessible from the outside;
step of performing a predetermined arithmetic operation using the secret data, simultaneously with the storage; and
step of outputting the result of the arithmetic operation to the outside.
35. (Previously Presented) A data storage verification method comprising:
fourth step of storing secret data in a storage means having a first area which is inaccessible from the outside;
fifth step of storing an inspection program which is a part of the secret data and is stored in the first area, into a storage means having a second area; and
sixth step of executing the inspection program stored in the second area to verify correctness of the secret data stored in the first area.
36. (Previously Presented) A data storage verification method as defined in Claim 35 further including seventh step of transferring control to a command of the first area after completion of the sixth step.

37. (Original) A data storage verification method as defined in Claim 35 wherein the fifth step executes storage of the inspection program according to a command that exists in the secret data stored in the first area.

38. (Original) A data storage verification method as defined in Claim 35 wherein the fifth step executes the inspection program according to a command that has been stored in a third area before execution of storage in the fourth step.

39. (Previously Presented) A data storage verification method comprising:
step of decrypting secret data;
step of storing the decrypted data in a storage means having an area which is inaccessible from the outside;
step of encrypting the stored data; and
step of comparing the encrypted data with the secret data to judge whether the stored data is correctly stored or not.

40. (Canceled)

41. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 2 further including, in the semiconductor integrated circuit, a decryption means for decrypting the encrypted rewrite program;

wherein, when the rewrite program stored in the first storage means has previously been encrypted, the decryption means decrypts the encrypted program, and stores the decrypted rewrite program in the second storage means.

42. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 5 further including, in the semiconductor integrated circuit, a decryption means for decrypting the encrypted rewrite program;

wherein, when the rewrite program stored in the first storage means has previously been encrypted, the decryption means decrypts the encrypted program, and stores the decrypted rewrite program in the second storage means.

43. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 7 further including, in the semiconductor integrated circuit, a decryption means for decrypting the encrypted rewrite program;

wherein, when the rewrite program stored in the first storage means has previously been encrypted, the decryption means decrypts the encrypted program, and stores the decrypted rewrite program in the second storage means.

44. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 8 further including, in the semiconductor integrated circuit, a decryption means for decrypting the encrypted rewrite program;

wherein, when the rewrite program stored in the first storage means has previously been encrypted, the decryption means decrypts the encrypted program, and stores the decrypted rewrite program in the second storage means.

45. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 16 wherein, when data are not correctly stored in the second storage means, a defective portion is detected, and the rewrite program stored in the first storage means is corrected.

46. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 2 wherein the rewrite program that is stored outside the semiconductor integrated circuit device is downloadable into the semiconductor integrated circuit.

47. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 5 wherein the rewrite program that is stored outside the semiconductor integrated circuit device is downloadable into the semiconductor integrated circuit.

48. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 7 wherein the rewrite program that is stored outside the semiconductor integrated circuit device is downloadable into the semiconductor integrated circuit.

49. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 8 wherein the rewrite program that is stored outside the semiconductor integrated circuit device is downloadable into the semiconductor integrated circuit.

50. (Previously Presented) A semiconductor integrated circuit device as defined in Claim 16 wherein the rewrite program that is stored outside the semiconductor integrated circuit device is downloadable into the semiconductor integrated circuit.